

TPD4S014 USB Charger Port Protection Including ESD Protection for all Lines and Over Voltage Protection on V_{BUS}

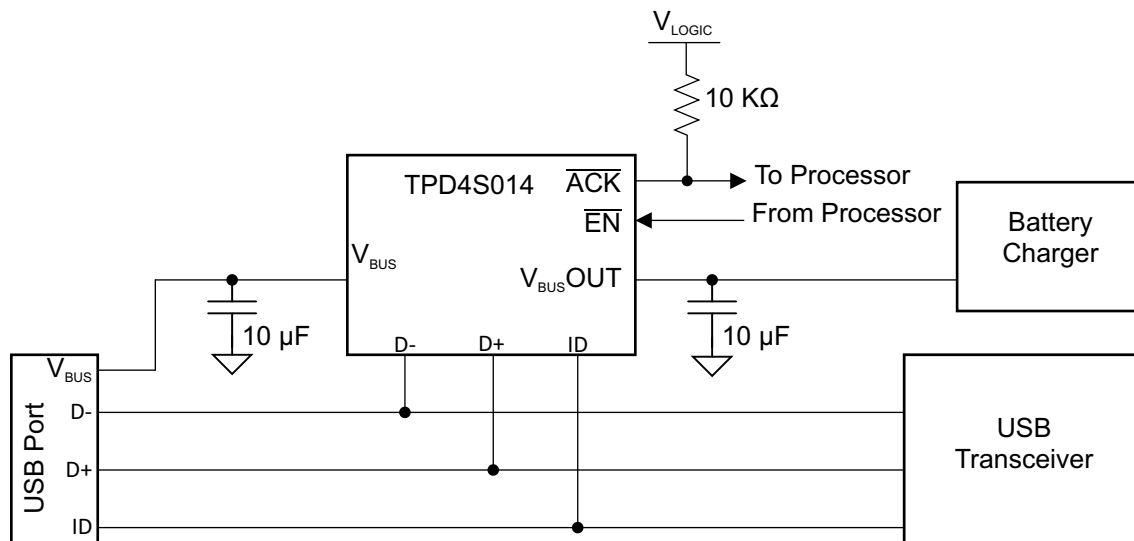
1 Features

- Input Voltage Protection at V_{BUS} up to 28 V
- Low Ron nFET Switch
- Supports > 2 A Charging Current
- ESD Performance D+/D-/ID/ V_{BUS} Pins:
 - ± 15 -kV Contact Discharge (IEC 61000-4-2)
 - ± 15 -kV Air Gap Discharge (IEC 61000-4-2)
- Over Voltage and Under Voltage Lockout Features
- Low Capacitance TVS ESD Clamp for USB2.0 High Speed Data Rate
- Internal 17 ms Startup Delay
- Integrated Input Enable and Status Output Signal
- Thermal Shutdown Feature
- Space Saving SON Package (2 mm x 2 mm)

2 Applications

- Cell Phones
- eBook
- Portable Media Players
- Digital Camera

4 Simplified Schematic



3 Description

The TPD4S014 is a single-chip solution for USB charger port protection. This device offers low capacitance Transient Voltage Suppressor (TVS) Electrostatic Discharge (ESD) clamps for the D+, D- and standard capacitance for the ID pin. On the V_{BUS} pin, this device provides Over Voltage Protection (OVP) up to 28 V DC. The over voltage lockout feature ensures that if there is a fault condition at the V_{BUS} line, the TPD4S014 is able to isolate the V_{BUS} line to protect the internal circuitry from damage. There is a 17 ms turn-on delay after V_{BUS} rises above the Under Voltage Lockout (UVLO) threshold in order to let the voltage stabilize before turning the nFET on. This function acts as a de-glitch and prevents unnecessary switching if there is any ringing on the line during connection.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
TPD4S014	SON (10)	2.00 mm x 2.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.



Table of Contents

1 Features	1	8 Detailed Description	9
2 Applications	1	8.1 Overview	9
3 Description	1	8.2 Functional Block Diagram	9
4 Simplified Schematic	1	8.3 Feature Description	9
5 Revision History	2	8.4 Device Functional Modes	11
6 Pin Configuration and Functions	3	9 Applications and Implementation	12
7 Specifications	4	9.1 Application Information	12
7.1 Absolute Maximum Ratings	4	9.2 Typical Application	12
7.2 Handling Ratings	4	10 Power Supply Recommendations	14
7.3 Recommended Operating Conditions	4	11 Layout	15
7.4 Thermal Information	5	11.1 Layout Guidelines	15
7.5 Electrical Characteristics, \overline{EN} , \overline{ACK} , D+, D-, ID Pins	5	11.2 Layout Example	15
7.6 Electrical Characteristics OVP Circuits	6	12 Device and Documentation Support	16
7.7 Supply Current Consumption	6	12.1 Trademarks	16
7.8 Thermal Shutdown Feature	6	12.2 Electrostatic Discharge Caution	16
7.9 Typical Characteristics	7	12.3 Glossary	16
		13 Mechanical, Packaging, and Orderable Information	16

5 Revision History

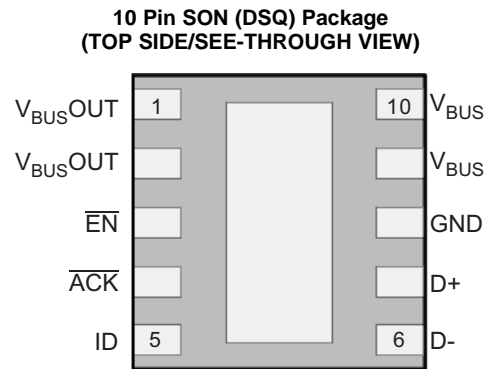
Changes from Revision D (April 2014) to Revision E	Page
• Updated Recommended Operating Conditions table.	4
• Changed	5
• Updated Electrical Characteristics OVP Circuits table.	6
• Changed t_{ON} MAX value from 18 ms to 22ms	6
• Changed t_{OFF} 8 μ s value from MAX to TYP	6
• Changed $t_{d(OVP)}$ 11 μ s value from MAX to TYP.	6
• Changed t_{REC} MAX value from 9 ms to 10.5 ms.	6
• Updated Application and Implementation section.	12

Changes from Revision C (December 2011) to Revision D	Page
• Added Handling Ratings table.	4
• Added Recommended Operating Conditions table.	4
• Added Thermal Information table.	5
• Updated Electrical Characteristics OVP Circuits table.	6

Changes from Revision B (October 2011) to Revision C	Page
• Made changes to the datasheet to tighten the parameters, VOP+ changed from 5.55V to 5.9V	1
• Updated Description.	1

Changes from Revision A (June 2011) to Revision B	Page
• Changed name of V_{CC} to V_{BUSOUT} throughout the entire document.	9
• Deleted row from Device Operation table.	11
• Added Eye Diagrams to Typical Characteristics section.	13

6 Pin Configuration and Functions



Pin Functions

PIN		TYPE	DESCRIPTION
NAME	NO.		
V_{BUSOUT}	1, 2	Power Output	Connect to PCB internal PCB plane
\overline{EN}	3	IO	Enable Active-Low Input. Drive EN low to enable the switch. Drive \overline{EN} high to disable the switch.
\overline{ACK}	4	I	Open-Drain Adapter-Voltage Indicator Output. \overline{ACK} is driven low after the V_{IN} voltage is stable between UVLO and OVLO for 17 ms (typ). Connect a pullup resistor from \overline{ACK} to the logic I/O voltage of the host system.
ID	5	IO	ESD-protected line
D-	6	IO	ESD-protected line
D+	7	IO	ESD-protected line
GND	8	Ground	Ground
V_{BUS}	9, 10	USB Input Power	Connector Side of V_{BUS}
Central PAD	Central PAD	Heat Sink	Electrically disconnected. Use as heat sink. Connect to GND plane via large PCB PAD

7 Specifications

7.1 Absolute Maximum Ratings⁽¹⁾⁽²⁾

over operating free-air temperature range (unless otherwise noted)

	VALUE		UNIT
	MIN	MAX	
Maximum junction temperature	-40	150	°C
Max Voltage on V _{BUS}	-0.5	30	V
Continuous current through nFET		2.6	A
Continuous current through \overline{ACK}	-50	50	mA
Max Current through D+, D-, ID, V _{BUS} ESD clamps		50	mA
Max voltage on \overline{EN} , \overline{ACK} , D+, D-, ID, V _{BUS} OUT		6	V

- (1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.
- (2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.

7.2 Handling Ratings

		MIN	MAX	UNIT		
T _{stg}	Storage temperature range	-65	150	°C		
V _(ESD)	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	-2	2	kV	
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	-1	1		
		IEC 61000-4-2 Contact Discharge	D+, D-, ID, V _{BUS} pins	-15		15
		IEC 61000-4-2 Air-gap Discharge	D+, D-, ID, V _{BUS} pins	-15		15

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±2 kV may actually have higher performance.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as ±1 kV may actually have higher performance.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	TYP	MAX	UNIT
T _A	Operating free-air temperature	-40		85	°C
V _I	Input voltage range	V _{BUS} OUT		5.5	V
		V _{BUS}	-0.1	5.5	
		\overline{EN}	-0.1	5.5	
		\overline{ACK}	-0.1	5.5	
		D+, D-, ID,	-0.1	5.5	
I _{VBUS}	V _{BUS} continuous current ⁽¹⁾			2.0	A
C _{VBUS}	Capacitance on V _{BUS}		10		μF
C _{VBUS} OUT	Capacitance on V _{BUS} OUT		10		μF
R _{ACK}	Pull up resistor on \overline{ACK}		10		kΩ

- (1) I_{VBUS} Max value is dependent on ambient temperature. See [Thermal Shutdown](#) section.

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		TPD4S014		UNIT
		DSQ		
		8 PINS		
R _{θJA}	Junction-to-ambient thermal resistance	70.3		°C/W
R _{θJctop}	Junction-to-case (top) thermal resistance	46.3		
R _{θJB}	Junction-to-board thermal resistance	33.8		
ψ _{JT}	Junction-to-top characterization parameter	2.9		
ψ _{JB}	Junction-to-board characterization parameter	33.5		
R _{θJcbot}	Junction-to-case (bottom) thermal resistance	16.3		

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

7.5 Electrical Characteristics, \overline{EN} , \overline{ACK} , D+, D–, ID Pins

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IH}	High-level input voltage \overline{EN}	Load current = 50 μA	1			V
V _{IL}	Low-level input voltage \overline{EN}	Load current = 50 μA			0.5	V
I _{LEAK}	Input Leakage Current \overline{EN} , D+, D–, ID	V _{IO} = 3.3 V			1	μA
V _{OL}	Low-level output voltage \overline{ACK}	I _{OL} = 2 mA			0.1	V
V _D	Diode forward Voltage D+, D–, ID pins; lower clamp diode	I _O = 8 mA			0.95	V
ΔC _{IO}	Differential Capacitance between the D+, D– lines			0.03		pF
C _{IO}	Capacitance to GND for the D+, D– lines			1.6		pF
C _{IO-ID}	Capacitance to GND for the ID line			19		pF
V _R	Reverse stand-off voltage of D+, D– and ID pins			5		V
V _{BR}	Breakdown voltage D+, D–, ID pins	I _{BR} = 1 mA		6		V
V _{BR VBUS}	Breakdown voltage on V _{BUS}	I _{BR} = 1 mA		28		V
R _{DYN}	Dynamic on resistance D+, D–, ID clamps	I _I = 1 A		1		Ω

7.6 Electrical Characteristics OVP Circuits

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
INPUT UNDERVOLTAGE LOCKOUT							
V_{UVLO+}	Under-voltage lock-out, input power detected threshold rising	V_{BUS} increasing from 0 V to 5 V, No load on OUT pin		2.65	2.8	3	V
V_{UVLO-}	Under-voltage lock-out, input power detected threshold falling	V_{BUS} decreasing from 5 V to 0 V, No load on OUT pin		2.25	2.44	2.7	V
$V_{HYS-UVLO}$	Hysteresis on UVLO	Δ of V_{UVLO+} and V_{UVLO-}		150	360	550	mV
INPUT TO OUTPUT CHARACTERISTICS							
$R_{DS_VBUSWITCH}$	V_{BUS} switch resistance	$V_{BUS} = 5$ V, $I_{OUT} = 500$ mA			151	200	m Ω
t_{ON}	Turn-ON time	V_{BUS} increasing from 2.8 V to 4.75 V, $\overline{EN} = 0$ V, $R_L = 36$ Ω , $C_L = 10$ μ F		16	17.4	22	ms
t_{OFF}	Turn-OFF time	V_{BUS} decreasing from 2.44 V to 0.5 V, $\overline{EN} = 0$ V, $R_L = 36$ Ω , $C_L = 10$ μ F			8		μ s
INPUT OVERVOLTAGE PROTECTION (OVP)							
V_{OVP+}	Input over-voltage protection threshold rising	V_{BUS}	V_{BUS} increasing from 5 V to 7 V, No Load	5.9	6.15	6.45	V
V_{OVP-}	Input over-voltage protection threshold falling	V_{BUS}	V_{BUS} decreasing from 7 V to 5 V, No Load	5.75	5.98	6.24	V
$V_{HYS-OVP}$	Hysteresis on OVP	V_{BUS}	Δ of V_{OVP+} and V_{OVP-}	25	100	275	mV
$t_{d(OVP)}$	Over voltage delay	V_{BUS}	$R_L = 36\Omega$, $C_L = 10$ μ F; V_{BUS} increasing from 5 V to 7 V		11		μ s
t_{REC}	Recovery time from input over voltage condition	V_{BUS}	$R_L = 36\Omega$, $C_L = 10$ μ F; V_{BUS} decreasing from 7 V to 5 V		8	10.5	ms

7.7 Supply Current Consumption

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TYP	MAX	UNIT
I_{VBUS}	V_{BUS} Operating Current Consumption	No load on V_{BUS_OUT} pin, $V_{BUS} = 5$ V, $\overline{EN} = 0$ V		147.6	160	μ A
I_{VBUS_OFF}	V_{BUS} Operating Current Consumption	No load on V_{BUS_OUT} pin, $V_{BUS} = 5$ V, $\overline{EN} = 5$ V		111.8	120	μ A

7.8 Thermal Shutdown Feature

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
T_{SHDN}	Thermal Shutdown				144		$^{\circ}$ C
$T_{SHDN-HYS}$	Thermal-Shutdown Hysteresis				23		$^{\circ}$ C

7.9 Typical Characteristics

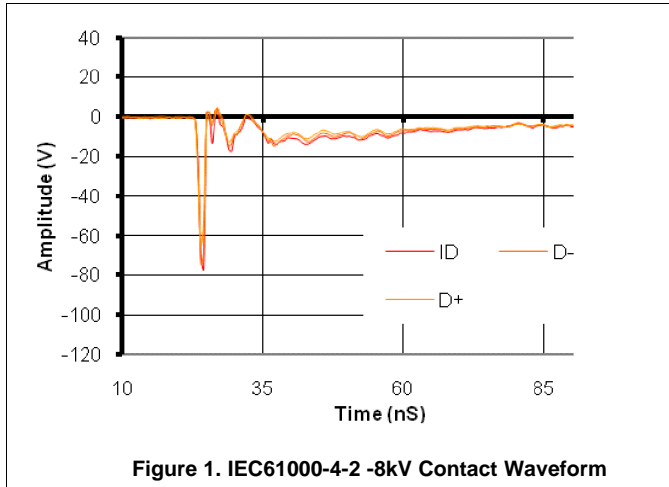


Figure 1. IEC61000-4-2 -8kV Contact Waveform

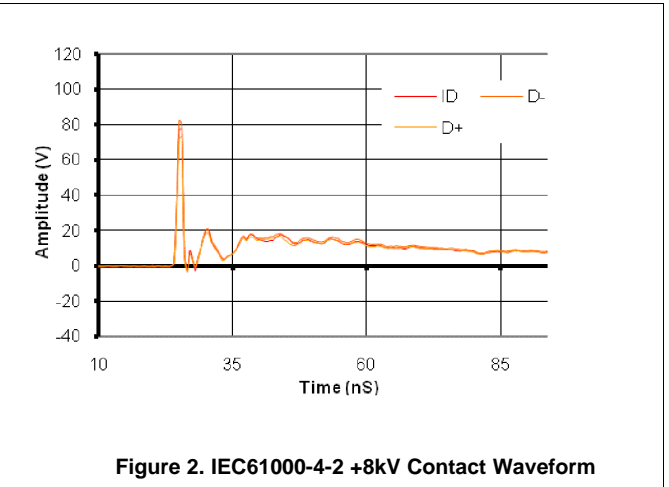


Figure 2. IEC61000-4-2 +8kV Contact Waveform

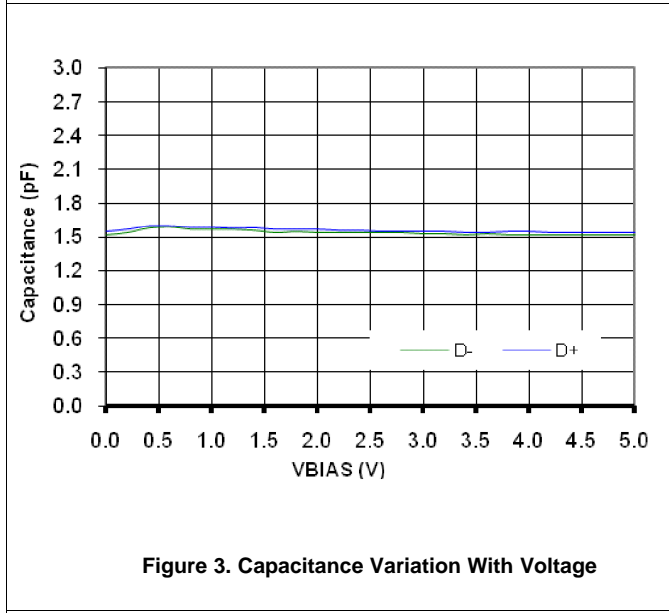


Figure 3. Capacitance Variation With Voltage

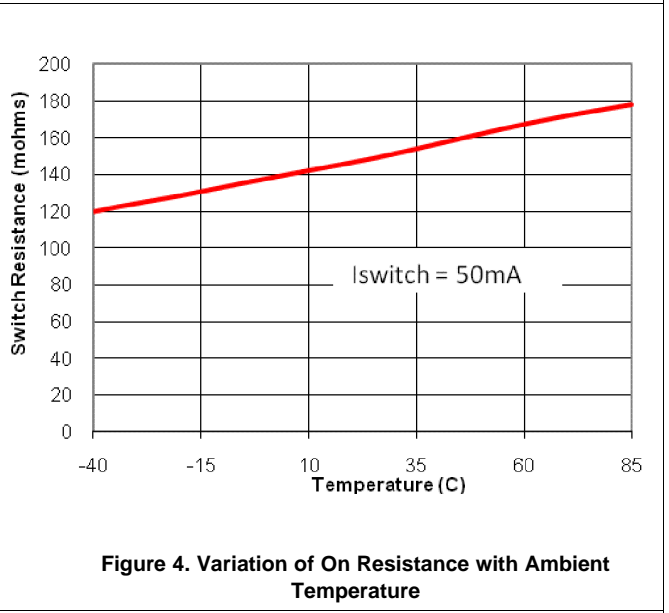


Figure 4. Variation of On Resistance with Ambient Temperature

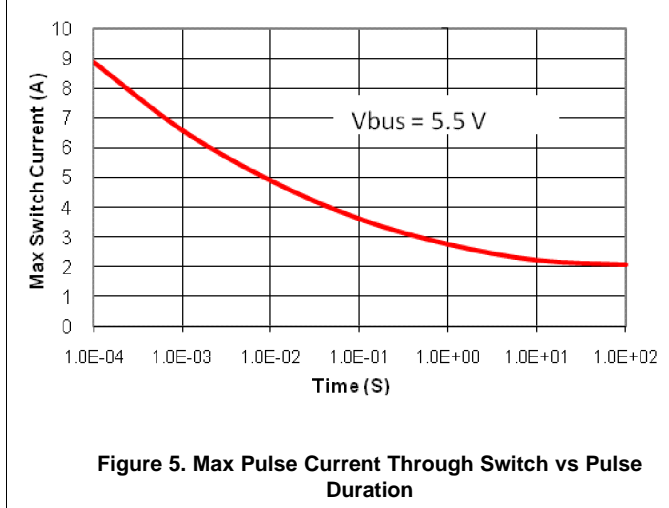


Figure 5. Max Pulse Current Through Switch vs Pulse Duration

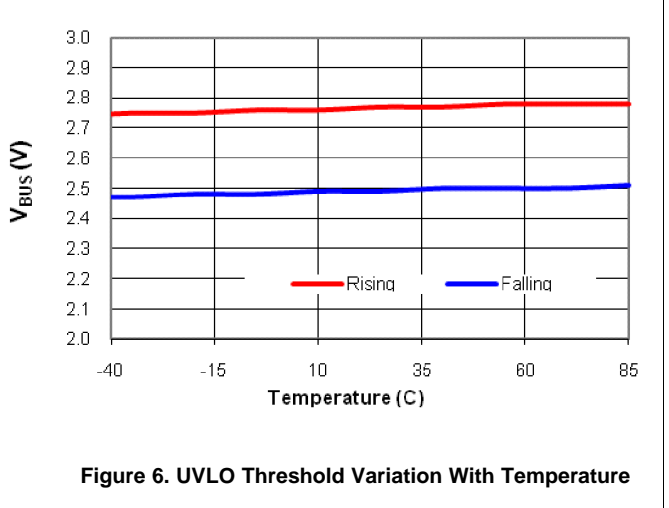
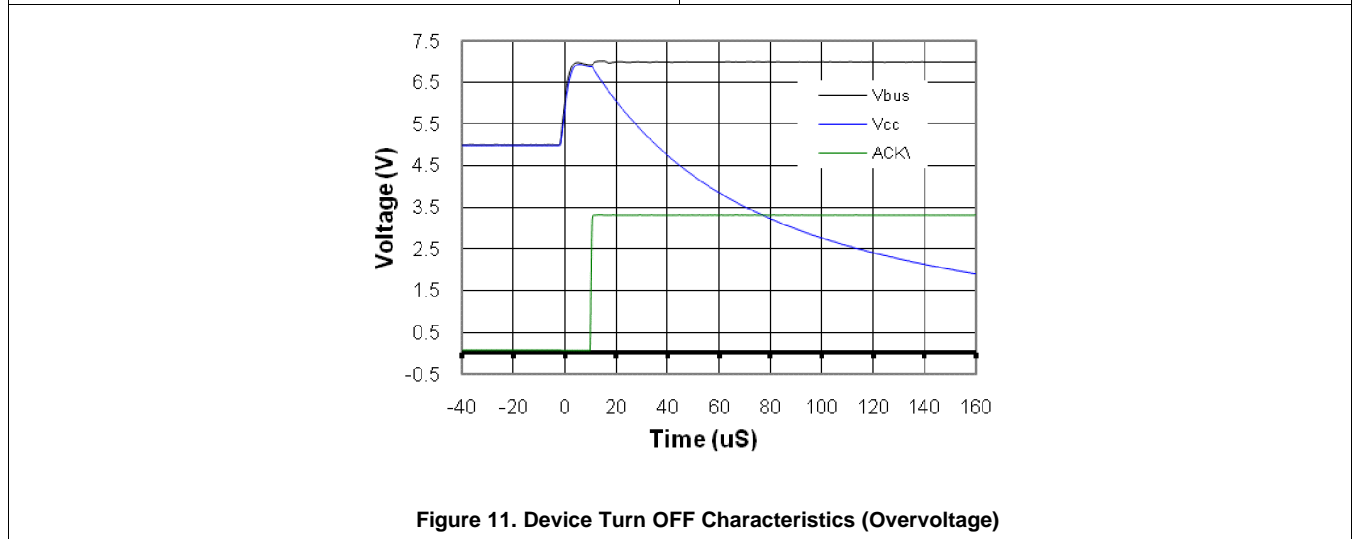
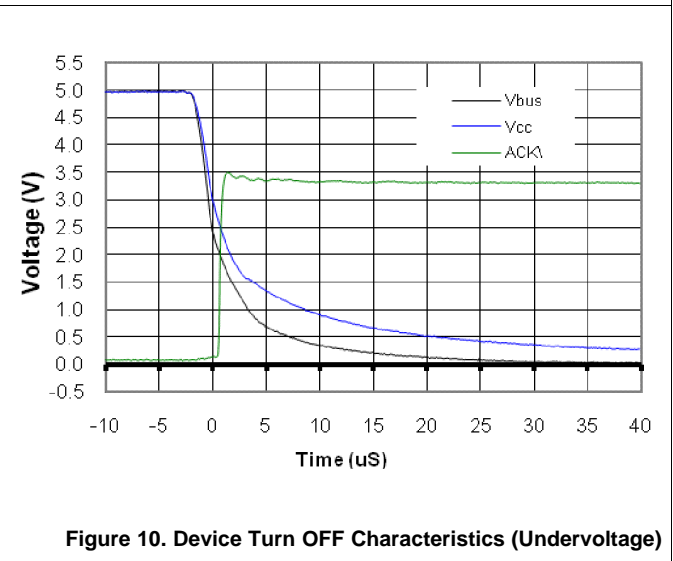
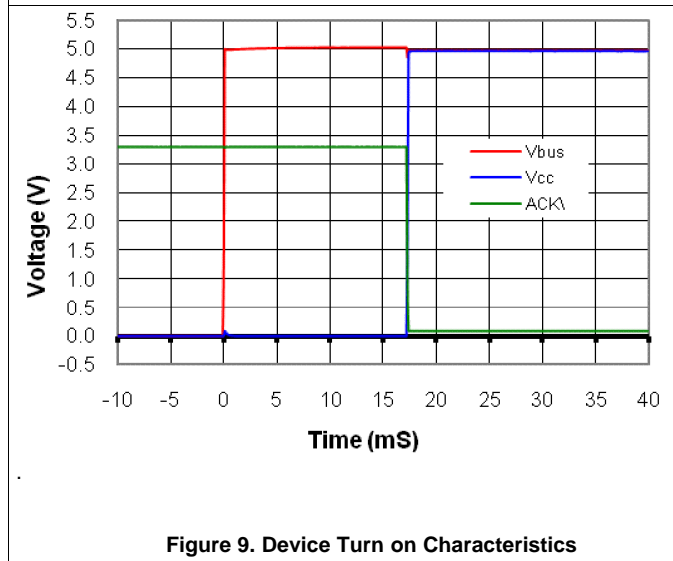
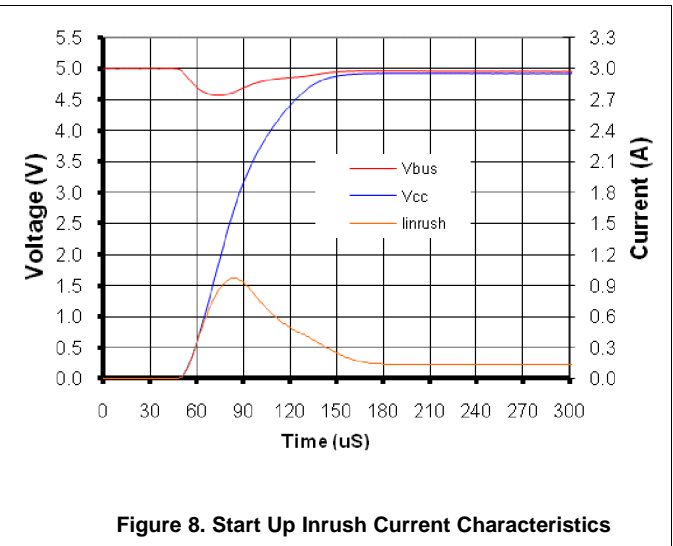
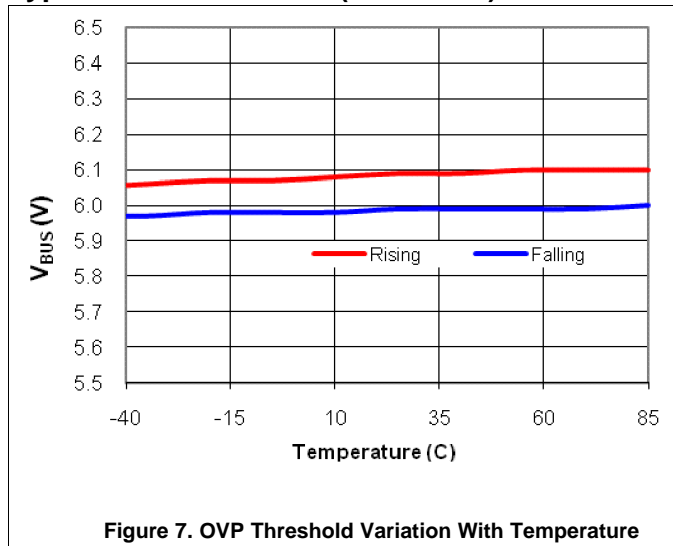


Figure 6. UVLO Threshold Variation With Temperature

Typical Characteristics (continued)

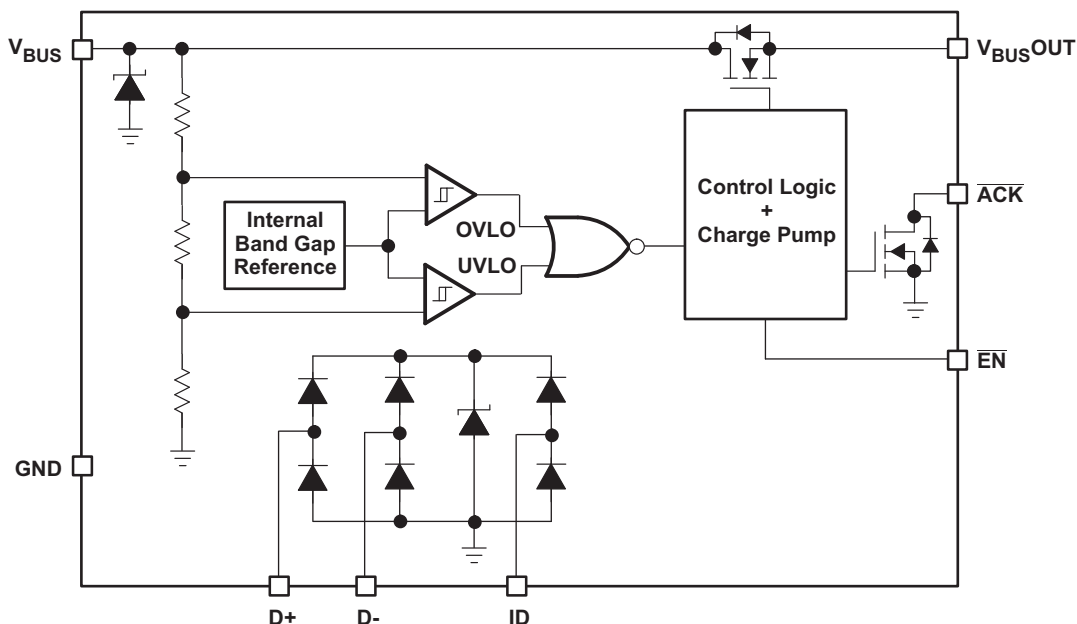


8 Detailed Description

8.1 Overview

The TPD4S014 provides a single-chip protection solution for USB charger interfaces. The V_{BUS} line is tolerant up to 28 V DC. A Low RON nFET switch is used to disconnect the downstream circuits in case of a fault condition. At power-up, when the voltage on V_{BUS} is rising, the switch will close 17 ms after the input crosses the under voltage threshold, thereby making power available to the downstream circuits. The TPD4S014 also has an \overline{ACK} output, which de-asserts to alert the system a fault has occurred. The TPD4S014 offers 4 channel ESD clamps for D+, D-, ID, and V_{BUS} pins that provide IEC61000-4-2 level 4 ESD protection. This eliminates the need for external TVS clamp circuits in the application.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Input Voltage Protection at V_{BUS} up to 28 V DC

When the input voltage rises above V_{OVP} , or drops below the V_{UVLO} , the internal V_{BUS} switch is turned off, removing power to the application. The \overline{ACK} signal is de-asserted when a fault condition is detected. If the fault was an over voltage event, the V_{BUS} nFET switch turns on 8ms (t_{REC}) after the input voltage returns below $V_{OVP} - V_{HYS_OVP}$ and remains above V_{UVLO} . If the fault was an under voltage event, the switch turns on 17 ms after the voltage returns above V_{UVLO+} (similar to start up). When the switch turns on, the \overline{ACK} is asserted once again.

8.3.2 Low RON nFET Switch

The nFET switch has a total on resistance (R_{ON}) of 151 m Ω . This equates to a voltage drop of less than 31 mV when charging at the maximum 2.0 A current level. Such low RON helps provide maximum potential to the system as provided by an external charger.

8.3.3 ESD Performance D+/D-/ID/ V_{BUS} Pins

The D+, D-, ID, and V_{BUS} pins can withstand ESD events up to ± 15 kV Contact and Air-Gap. An ESD clamp diverts the current to ground.

Feature Description (continued)

8.3.4 Over Voltage and Under Voltage Lockout Features

The over voltage and under voltage lockout feature ensures that if there is a fault condition at the V_{BUS} line, the TPD4S014 is able to isolate the V_{BUS} line and protect the internal circuitry from damage. Due to the body diode of the nFET switch, if there is a short to ground on V_{BUS} the system is expected to limit the current to V_{BUSOUT} .

8.3.5 Capacitance TVS ESD Clamp for USB2.0 Hi-Speed Data Rate

The D+/D– ESD protection pins have low capacitance so there is no significant impact to the signal integrity of the USB 2.0 Hi-Speed data rate.

8.3.6 Start-up Delay

Upon startup, TPD4S014 has a built in startup delay. An internal oscillator controls a charge pump to control the turn-on delay (t_{ON}) of the internal nFET switch. The internal oscillator controls the timers that enable the turn-on of the charge pump and sets the state of the open-drain \overline{ACK} output. If $V_{BUS} < V_{UVLO}$ or if $V_{BUS} > V_{OVLO}$, the internal oscillator remains off, thus disabling the charge pump. At any time, if V_{BUS} drops below V_{UVLO} or rises above V_{OVLO} , \overline{ACK} is released and the nFET switch is disabled.

8.3.7 OVP Glitch Immunity

A 17 ms deglitch time has been introduced into the turn on sequence to ensure that the input supply has stabilized before turning the nFET switch ON. Noise on the V_{BUS} line could turn ON the nFET switch when the fault condition is still active. To avoid this, OVP glitch immunity allows noise on the V_{BUS} line to be rejected. Such a glitch protection circuitry is also introduced in the turn off sequence in order to prevent the switch from turning off for voltage transients. The glitch protection circuitry integrates the glitch over time, allowing the OVP circuitry to trigger faster for larger voltage excursions above the OVP threshold and slower for shorter excursions.

8.3.8 Integrated Input Enable and Status Output Signal

External control of the nFET switch is provided by an active low \overline{EN} pin. An \overline{ACK} pin provides output logic to acknowledge V_{BUS} is between UVLO and OVP by asserting low.

8.3.9 Thermal Shutdown

When the device is ON, current flowing through the device will cause the device to heat up. Overheating can lead to permanent damage to the device. To prevent this, an over temperature protection has been designed into the device. Whenever the junction temperature exceeds 145°C, the switch will turn off, thereby limiting the temperature. The \overline{ACK} signal will be asserted for an over temperature event. Once the device cools down to below 120°C the \overline{ACK} signal will be de-asserted, and the switch will turn on if the EN is active and the V_{BUS} voltage is within the UVLO and OVP thresholds. While the over temperature protection in the device will not kick-in unless the die temperature reaches 145°C, it is generally recommended that care is taken to keep the junction temperature below 125 °C. Operation of the device above 125 °C for extended periods of time can affect the long-term reliability of the part.

The junction temperature of the device can be calculated using below formula:

$$T_j = T_a + P_D \theta_{JA} \quad (1)$$

T_j = Junction temperature

T_a = Ambient temperature

θ_{JA} = Thermal resistance

P_D = Power Dissipated in device

$$P_D = I^2 R_{on} \quad (2)$$

I = Current through device

R_{ON} = Max on resistance of device

Feature Description (continued)

Example

At 2-A continuous current power dissipation is given by:

$$P_D = I^2 \times R_{DS(on)} = 2^2 \times 0.2 = 0.8W$$

If the ambient temperature is about 60°C the junction temperature will be:

$$T_j = T_a + (P_D \times \theta_{JA}) = 60 + (0.8 \times 70.3) = 116.24$$

This implies that, at an ambient temperature of 60°C, TPD4S014 can pass a continuous 2A without sustaining damage. Conversely, the above calculation can also be used to calculate the total continuous current the TPD4S014 can handle at any given temperature.

8.4 Device Functional Modes

OTP	UVLO	OVLO	\overline{EN}	SW	\overline{ACK}
X	H	X	X	OFF	H
X	X	H	X	OFF	H
L	L	L	H	OFF	L
L	L	L	L	ON	L
H	X	X	X	OFF	H

OTP = Over temperature protection circuit active

UVLO = Under voltage lock-out circuit active

OVLO = Over voltage lock-out circuit active

SW = Load switch

CP = Charge pump

X = Don't Care

H = True

L = False

9 Applications and Implementation

9.1 Application Information

The TPD4S014 is a single-chip solution for USB charger port protection. This device offers low capacitance TVS type ESD clamps for the D+, D– and standard capacitance for the ID pin. On the V_{BUS} pin, this device can handle over voltage protection up to 28 V. The over voltage lockout feature ensures that if there is a fault condition at the V_{BUS} line TPD4S014 is able to isolate the V_{BUS} line and protect the internal circuitry from damage. In order to let the voltage stabilize before closing the switch there is a 17 ms turn on delay after V_{BUS} crosses the UVLO threshold. This function acts as a de-glitch which prevents unnecessary switching if there is any ringing on the line during connection. Due to the body diode of the nFET switch, if there is a short to ground on V_{BUS} the system is expected to limit the current to V_{BUSOUT} .

9.2 Typical Application

9.2.1 For Non-OTG USB Systems

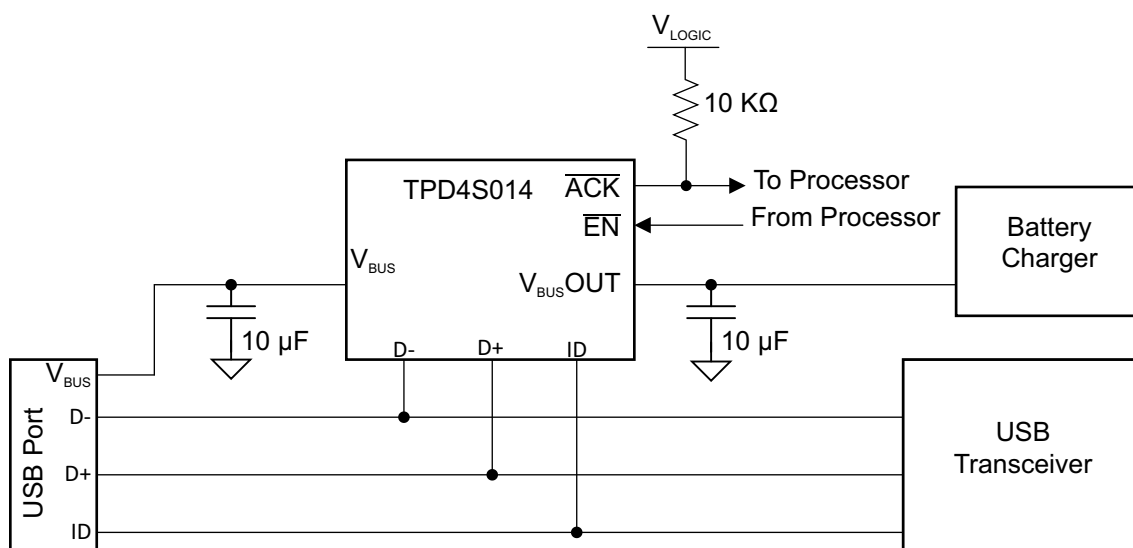


Figure 12. Non-OTG Schematic

9.2.1.1 Design Requirements

Design Parameters	Example Value
Signal range on V_{BUS}	3.3 V – 5.9 V
Signal range on V_{BUSOUT}	3.9 V – 5.9 V
Signal range on D+/D– and ID	0 V – 5 V
Drive \overline{EN} low (enabled)	0 V – 0.5 V
Drive \overline{EN} high (disabled)	1 V – 6 V

9.2.1.2 Detailed Design Procedure

To begin the design process, some parameters must be decided upon. The designer needs to know the following:

- V_{BUS} voltage range
- Processor logic levels V_{OH} , V_{OL} for \overline{EN} and V_{IH} , V_{IL} for \overline{ACK} pins

9.2.1.3 Application Curves

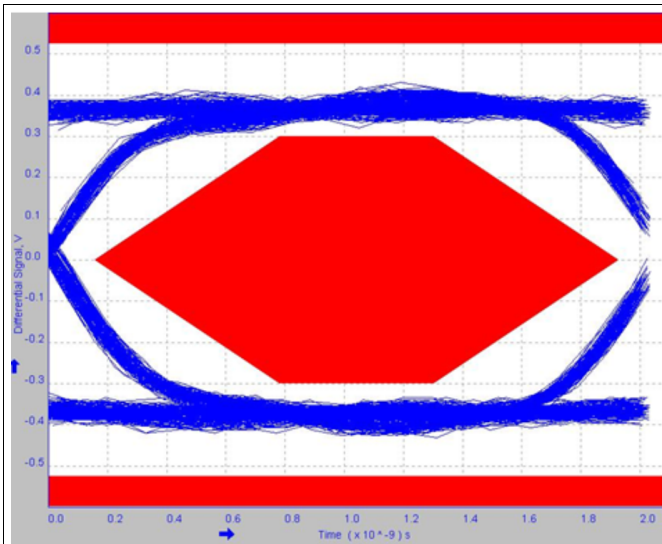


Figure 13. Eye Diagram With No EVM And No IC, Full USB2.0 Speed At 480Mbps

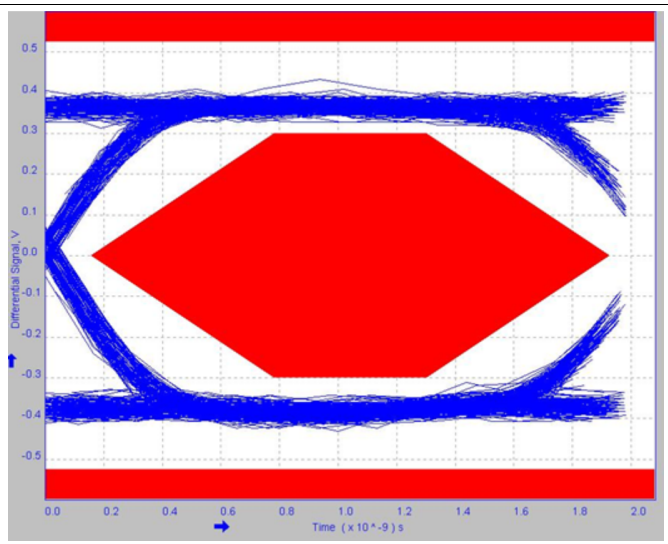


Figure 14. Eye Diagram With EVM, No IC, Full USB2.0 Speed At 480Mbps

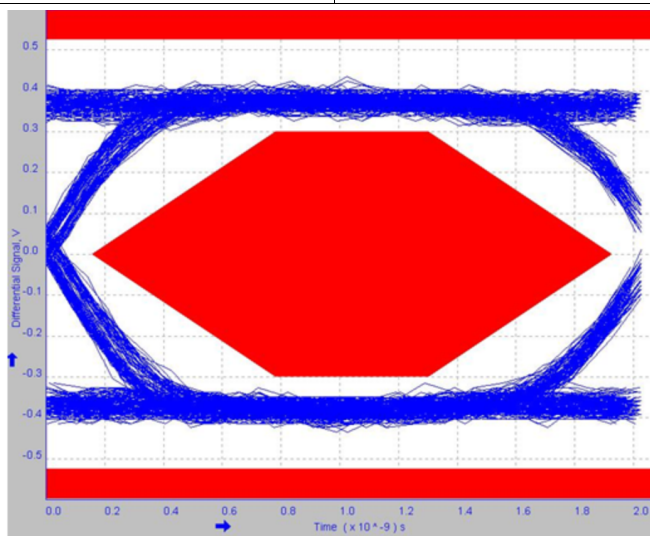


Figure 15. Eye Diagram With EVM and IC, Full USB2.0 Speed At 480Mbps

9.2.2 For OTG USB Systems

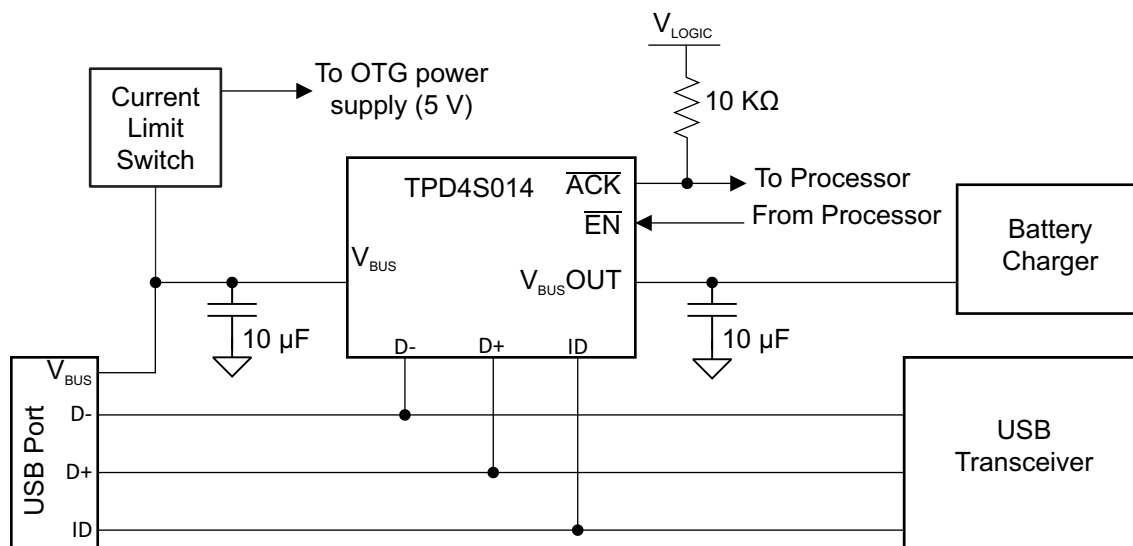


Figure 16. OTG Schematic

9.2.2.1 Design Requirements

Design Parameters	Example Value
Signal range on V_{BUS}	3.3 V – 5.9 V
Signal range on V_{BUSOUT}	3.9 V – 5.9 V
Signal range on D+/D– and ID	0 V – 5 V
Drive \overline{EN} low (enabled)	0 V – 0.5 V
Drive \overline{EN} high (disabled)	1 V – 6 V

9.2.2.2 Detailed Design Procedure

To begin the design process, some parameters must be decided upon. The designer needs to know the following:

- V_{BUS} voltage range
- Processor logic levels V_{OH} , V_{OL} for \overline{EN} and V_{IH} , V_{IL} for \overline{ACK} pins
- OTG power supply output voltage range

9.2.2.3 Application Curves

Refer to [Application Curves](#) in the previous section.

10 Power Supply Recommendations

TPD4S014 is designed to receive power from a USB 3.0 (or lower) V_{BUS} source. It can operate normally (nFET ON) between 3.0 V and 5.9 V. Thus, the power supply (with a ripple of V_{RIPPLE}) requirement for TPD4S014 to be able to switch the nFET ON is between $3.0\text{ V} + V_{RIPPLE}$ and $5.9\text{ V} - V_{RIPPLE}$.

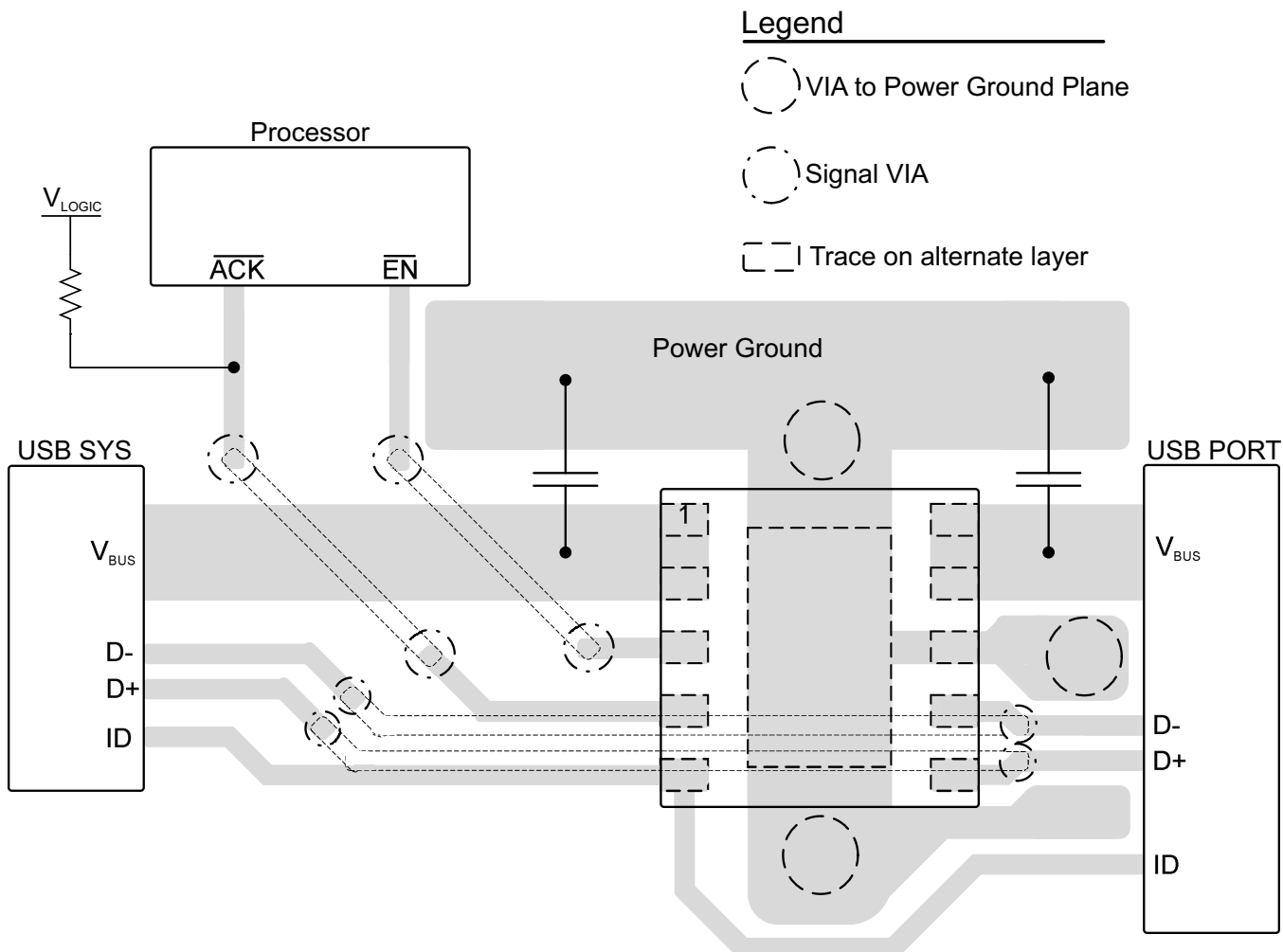
11 Layout

11.1 Layout Guidelines

- The optimum placement is as close to the connector as possible.
 - EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures.
 - The PCB designer needs to minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.
 - Keep traces between the connector and TPD4S014 on the same layer as TPD4S014.
- Route the protected traces as straight as possible.
- Eliminate any sharp corners on the protected traces between the TVS and the connector by using rounded corners with the largest radii possible.
 - Electric fields tend to build up on corners, increasing EMI coupling.

When designing layout for TPD4S014, note that V_{BUSOUT} and V_{BUS} pins allow for extra wide traces for good power delivery. In the example shown, these pins are routed with 25 mil (0.64 mm) wide traces. Place the V_{BUSOUT} and V_{BUS} capacitors as close to the device pins as possible. Pull \overline{ACK} up to the Processor logic level high with a resistor. Use external and internal ground planes and stitch them together with VIAs as close to the GND pins of TPD4S014 as possible. This allows for a low impedance path to ground so that the device can properly dissipate any ESD events.

11.2 Layout Example



12 Device and Documentation Support

12.1 Trademarks

All trademarks are the property of their respective owners.

12.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.3 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms and definitions.

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TPD4S014DSQR	ACTIVE	WSON	DSQ	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ZTE	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSELETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

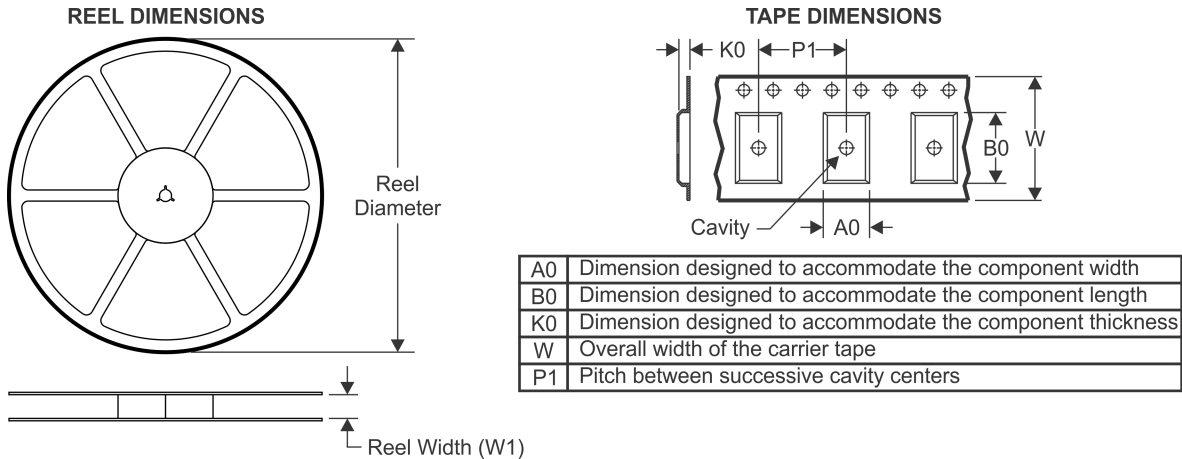
(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPD4S014DSQR	WSON	DSQ	10	3000	179.0	8.4	2.2	2.2	1.2	4.0	8.0	Q2

TAPE AND REEL BOX DIMENSIONS

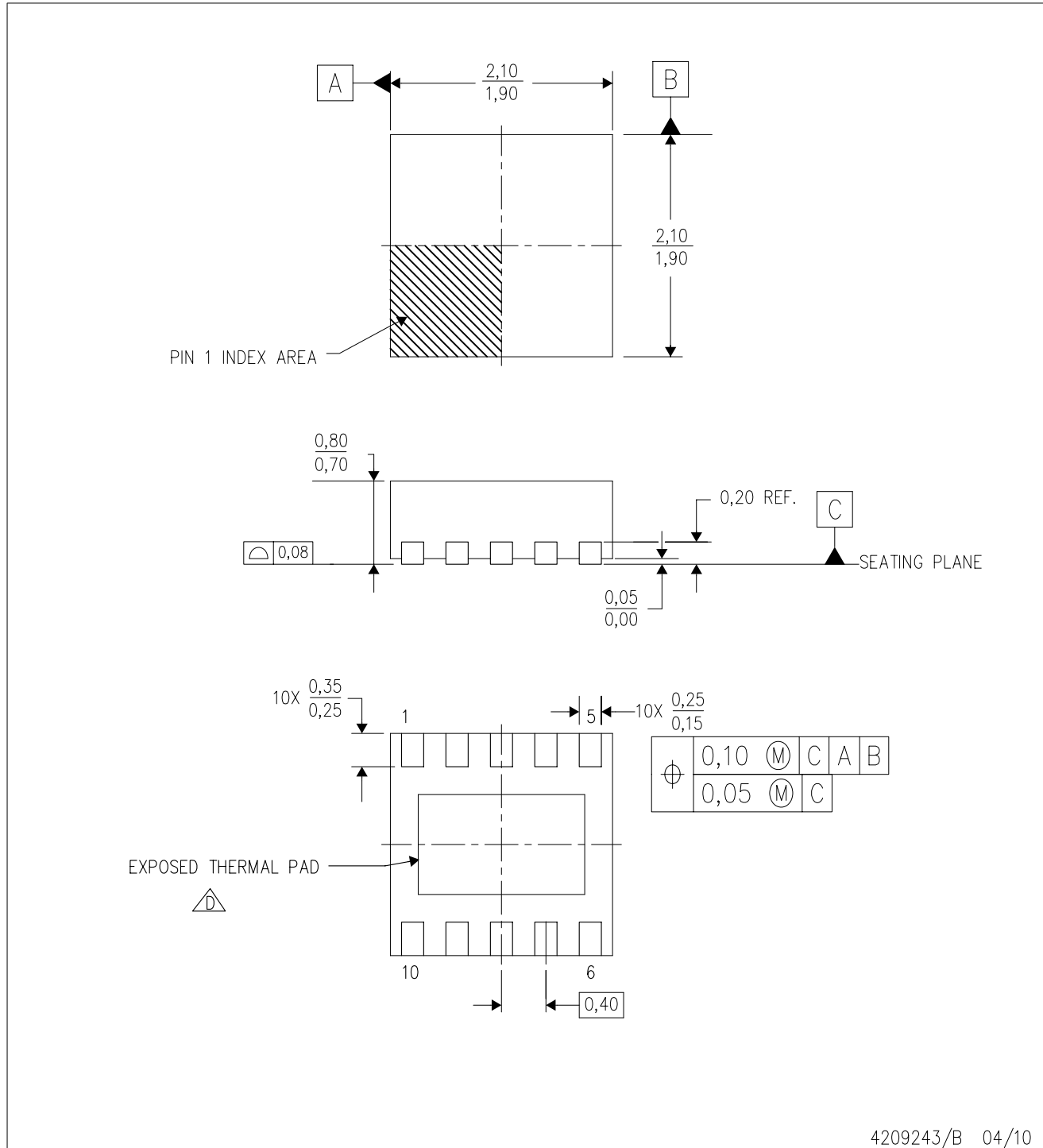


*All dimensions are nominal


Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPD4S014DSQR	WSON	DSQ	10	3000	195.0	200.0	45.0

DSQ (S-PWSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



4209243/B 04/10

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Small Outline No-Lead (SON) package configuration.
 -  D. The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.

THERMAL PAD MECHANICAL DATA

DSQ (R-PWSON-N10)

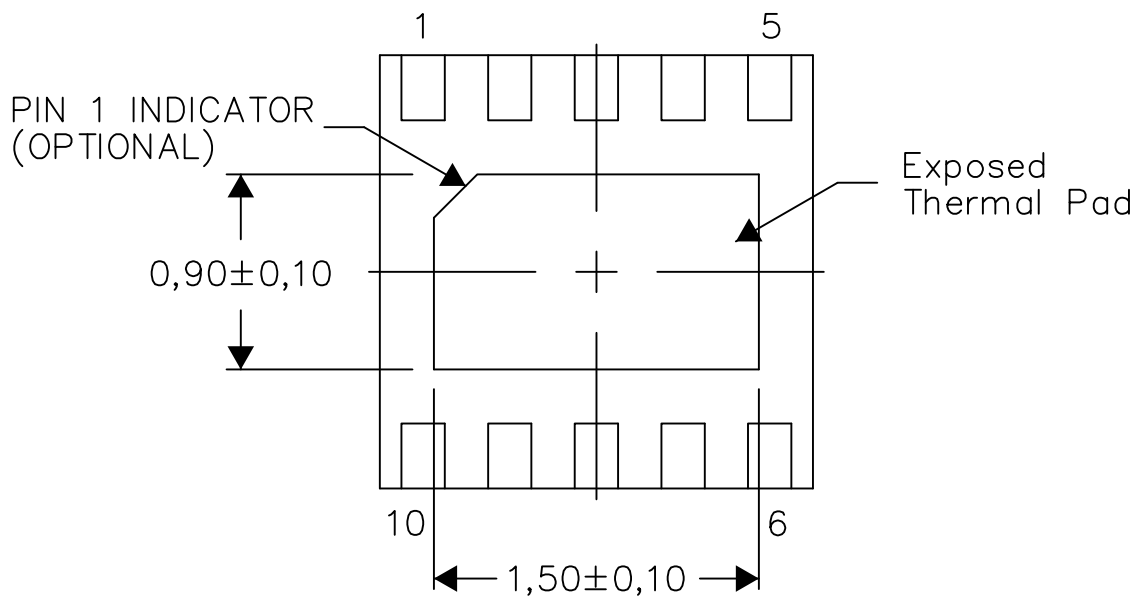
PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

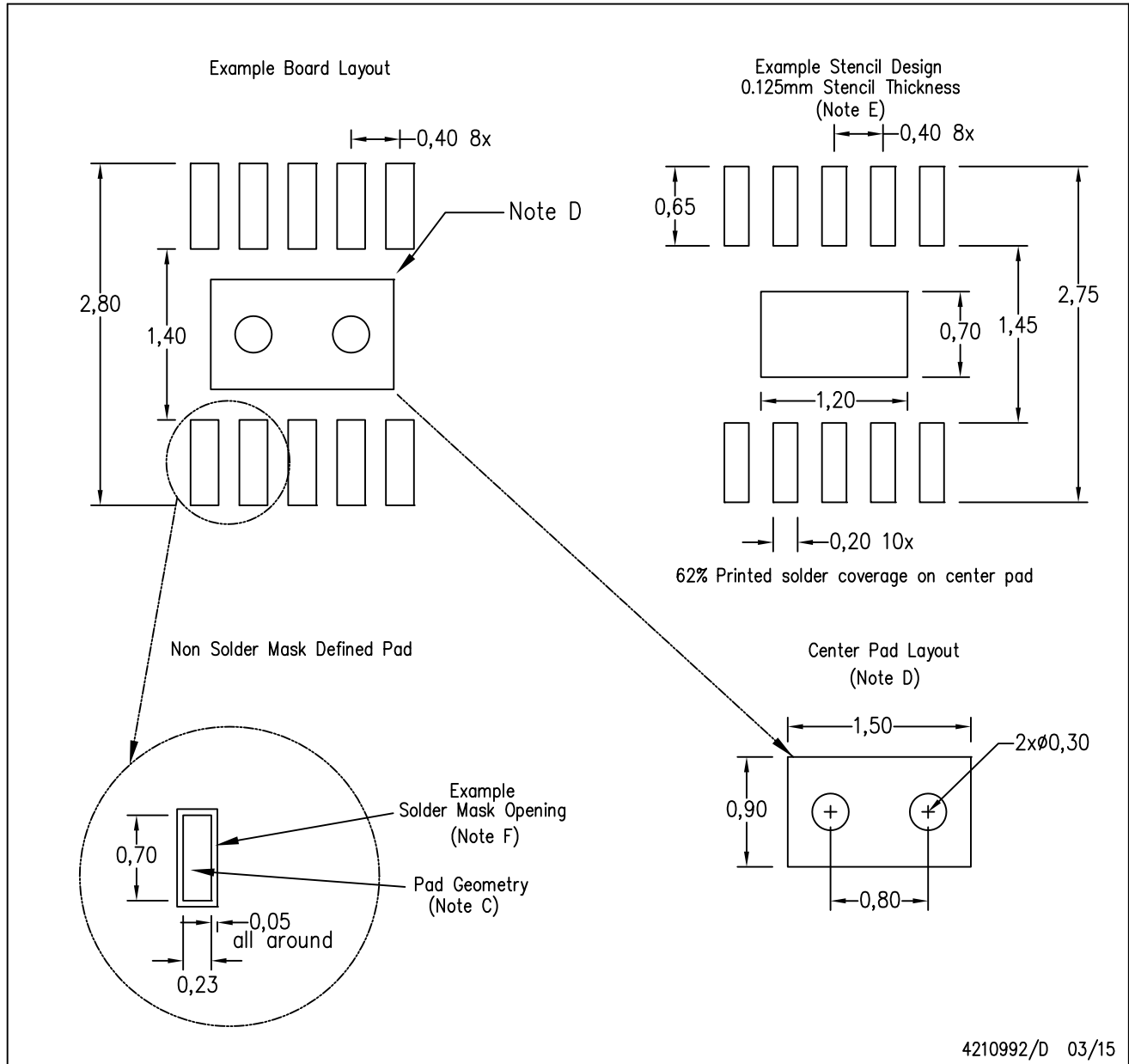
Exposed Thermal Pad Dimensions

4210993/D 03/15

NOTES: A. All linear dimensions are in millimeters

DSQ (R-PWSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Publication IPC-7351 is recommended for alternate designs.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - F. Customers should contact their board fabrication site for solder mask tolerances.

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have **not** been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products

Audio	www.ti.com/audio
Amplifiers	amplifier.ti.com
Data Converters	dataconverter.ti.com
DLP® Products	www.dlp.com
DSP	dsp.ti.com
Clocks and Timers	www.ti.com/clocks
Interface	interface.ti.com
Logic	logic.ti.com
Power Mgmt	power.ti.com
Microcontrollers	microcontroller.ti.com
RFID	www.ti-rfid.com
OMAP Applications Processors	www.ti.com/omap
Wireless Connectivity	www.ti.com/wirelessconnectivity

Applications

Automotive and Transportation	www.ti.com/automotive
Communications and Telecom	www.ti.com/communications
Computers and Peripherals	www.ti.com/computers
Consumer Electronics	www.ti.com/consumer-apps
Energy and Lighting	www.ti.com/energy
Industrial	www.ti.com/industrial
Medical	www.ti.com/medical
Security	www.ti.com/security
Space, Avionics and Defense	www.ti.com/space-avionics-defense
Video and Imaging	www.ti.com/video

TI E2E Community

e2e.ti.com